

<b>Notice of References Cited</b>	Application/Control No. 09/640,729	Applicant(s)/Patent Under Reexamination HERTWIG ET AL.	
	Examiner Raymond Phan	Art Unit 2181	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
/	A	US-6353863	03-2002	Nakagawa et al.	710/5
/	B	US-6526462	02-2003	Elabd	710/242
/	C	US-5867726	02-1999	Ohsuga et al.	709/20
/	D	US-4881164	11-1989	Hailpern et al.	711/207
/	E	US-5903771	05-1999	Sgro et al.	712/20
/	F	US-6163828	12-2000	Landi et al.	710/240
/	G	US-5685005	11-1997	Garde et al.	712/1
/	H	US-5592677	01-1997	Intrater et al.	712/1
/	I	US-5974493	10-1999	Okummura et al.	710/127
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1 067 461 A1	08-1999	EPO	Chauvel et al.	G06F 13/16
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.